

STADIVARI

THE FASTEST AND
MOST FLEXIBLE
WAY TO EXPLORE
RECIPROCAL SPACE



SINGLE CRYSTAL DIFFRACTOMETRY

- Flexible goniometer (Eulerian cradle, horizontal & vertical, synchrotron and custom setups)
- Sphere of confusion < 5 μm (radius)
- Various sources (Microfocus BDS etc.)
- Ultrafast hybrid pixel detectors

YOUR PARTNER IN X-RAY DIFFRACTION

STOE & Cie GmbH | WWW.STOE.COM

STADIVARI

RAPID, COMPREHENSIVE AND EXTREMELY VERSATILE ANALYSIS OF A WIDE VARIETY OF MATERIALS

SOURCES

- Standard sealed tubes (Ag, Mo, Cu)
- Conventional & high performance microfocus sources (Ag, Mo, Cu)
- MetalJet (In or Ga alloy) X-ray source
- Synchrotron

OPEN EULERIAN CRADLE

- High precision
- Sphere of confusion < 5 μm (radius)
- Virtually maintenance-free
- State of the art interface

WORLD-LEADING DETECTORS

- DECTRIS PILATUS4 or EIGER2 series
- CMOS hybrid-pixel technology
- Single-photon-counting mode
- No dark current
- Ultra-fast data collection as well as ultra-long exposure times

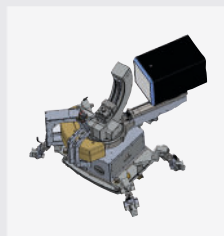


Horizontal and vertical setups, along with the ability to measure single crystalline and powdered samples, broaden the scope of experimental options with the **STADIVARI**. In addition, the open Eulerian Cradle provides ample space for integrating high

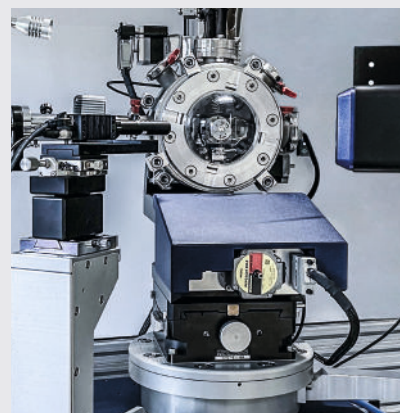
pressure cells, high- or low-temperature devices, and other chambers. As the newest member of the long line of STOE diffractometers, the **STADIVARI** is fully integrated into the well-established STOE X-Area software package.

FLEXIBLE GONIOMETER SETUP

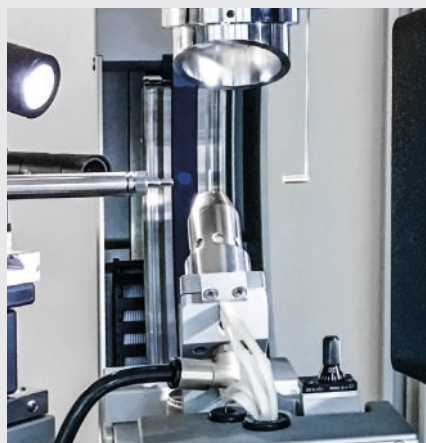
STADIVARI goniometers can be manufactured in various geometries (e.g. horizontal or vertical) and equipped with **a range of sources** from microfocus to full beamline implementation.



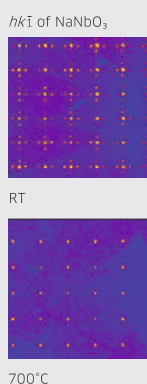
Synchrotron



Heavy Load / Custom



Heatstream Setup



HEATSTREAM

The STOE HEATSTREAM covers a temperature range from **room temperature to 1000 K**. An open flow of N_2 is used as heating medium and ensures constant thermal conditions with an accuracy of ± 1 K for the sample at any diffractometer position.

XYZ STAGES

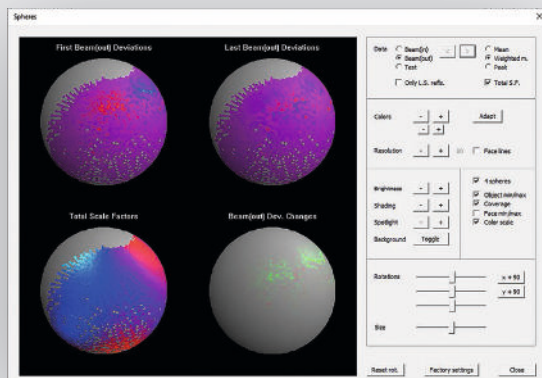
The light load stage has a protective cover against low temperatures while the heavy load stage is designed for 55 mm diameter DACs. Both xyz stages are based on an IUCr mount, have a **resolution of movement of $< 1.5 \mu\text{m}$** and a minimal number of cables.



Light Load



Heavy Load



SPHERES Visualization Tool

X-AREA

X-Area is STOE's software for easy data collection and evaluation, and it is a powerful tool for analyzing complicated structures, including multi-domain and modulated crystals. It features **visualization tools for data treatment and quality control**, supports DAC data and can even evaluate powder patterns.

SYSTEM SPECIFICATIONS

The **STOE STADIVARI** X-ray diffraction system combines precision and versatility in an easily accessible housing which provides space to let your experimental creativity flow. It offers exceptional structural analyses with a sphere of confusion $< 5 \mu\text{m}$ in radius. The goniometer encompasses wide angular ranges of up to: 2θ : 240° , ω : 205° , χ : 90° , φ : 360° , while the detector distance ranges from 40–140 mm. Supporting X-ray sources from microfocus sources to synchrotrons, it makes tailor made experimentation possible. Detectors and sources are connected with a closed-circuit, independent water cooling system to prevent excess heat impacting your measurement. Experience advanced structural analysis with the **STOE STADIVARI**.



PILATUS4 R 260K CdTe

Sensor thickness: **1000 μm**

Pixel size: **150 μm x 150 μm**

Energy range: **8 keV to 25 keV**

Readout time: **continuous readout with $< 100 \text{ ns}$ dead time**

EIGER2 R 1M CDTE

Sensor thickness: **750 μm**

Pixel size: **75 μm x 75 μm**

Energy range: **8 keV to 25 keV**

Readout time: **continuous readout with 100 ns dead time**



Other detectors on request.



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